

# SN54LVC574A, SN74LVC574A OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

SCAS301J – JANUARY 1993 – REVISED JULY 1998

- **EPIC™ (Enhanced-Performance Implanted CMOS) Submicron Process**
- **Typical  $V_{OLP}$  (Output Ground Bounce)  $< 0.8\text{ V}$  at  $V_{CC} = 3.3\text{ V}$ ,  $T_A = 25^\circ\text{C}$**
- **Typical  $V_{OHV}$  (Output  $V_{OH}$  Undershoot)  $> 2\text{ V}$  at  $V_{CC} = 3.3\text{ V}$ ,  $T_A = 25^\circ\text{C}$**
- **Support Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V  $V_{CC}$ )**
- **Power Off Disables Outputs, Permitting Live Insertion**
- **ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model ( $C = 200\text{ pF}$ ,  $R = 0$ )**
- **Latch-Up Performance Exceeds 250 mA Per JESD 17**
- **Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and DIPs (J)**

## description

The SN54LVC574A octal edge-triggered D-type flip-flop is designed for 2.7-V to 3.6-V  $V_{CC}$  operation and the SN74LVC574A octal edge-triggered D-type flip-flop is designed for 1.65-V to 3.6-V  $V_{CC}$  operation.

These devices feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels at the data (D) inputs.

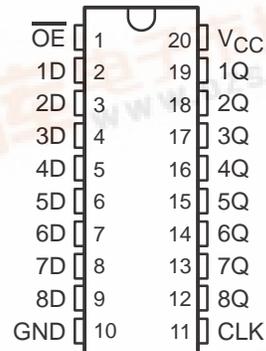
A buffered output-enable ( $\overline{OE}$ ) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

$\overline{OE}$  does not affect the internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

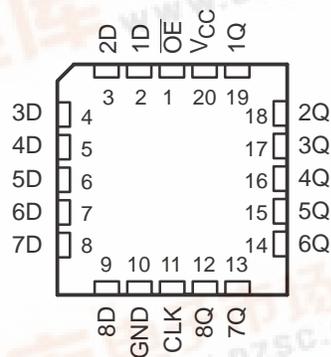
To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

SN54LVC574A . . . J OR W PACKAGE  
SN74LVC574A . . . DB, DW, OR PW PACKAGE  
(TOP VIEW)



SN54LVC574A . . . FK PACKAGE  
(TOP VIEW)



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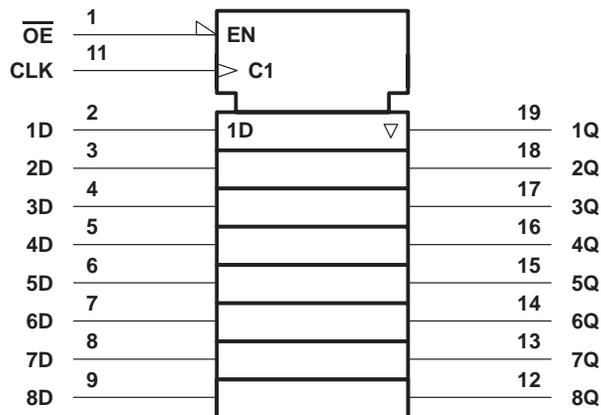
## description (continued)

The SN54LVC574A is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74LVC574A is characterized for operation from  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

FUNCTION TABLE  
(each flip-flop)

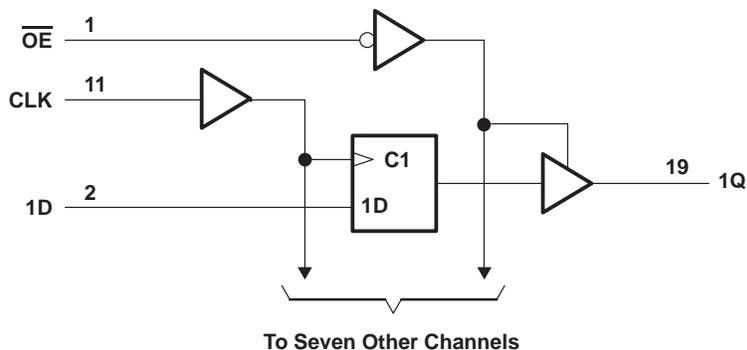
INPUTS			OUTPUT
$\overline{\text{OE}}$	CLK	D	Q
L	$\uparrow$	H	H
L	$\uparrow$	L	L
L	L	X	$Q_0$
H	X	X	Z

## logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## logic diagram (positive logic)



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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, $V_{CC}$ .....	–0.5 V to 6.5 V
Input voltage range, $V_I$ (see Note 1) .....	–0.5 V to 6.5 V
Voltage range applied to any output in the high-impedance or power-off state, $V_O$ (see Note 1) .....	–0.5 V to 6.5 V
Voltage range applied to any output in the high or low state, $V_O$ (see Notes 1 and 2) .....	–0.5 V to $V_{CC} + 0.5$ V
Input clamp current, $I_{IK}$ ( $V_I < 0$ ) .....	–50 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ ) .....	–50 mA
Continuous output current, $I_O$ .....	±50 mA
Continuous current through $V_{CC}$ or GND .....	±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3): DB package .....	115°C/W
DW package .....	97°C/W
PW package .....	128°C/W
Storage temperature range, $T_{stg}$ .....	–65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.  
 2. The value of  $V_{CC}$  is provided in the recommended operating conditions table.  
 3. The package thermal impedance is calculated in accordance with JESD 51.

## recommended operating conditions (see Note 4)

		SN54LVC574A		SN74LVC574A		UNIT
		MIN	MAX	MIN	MAX	
$V_{CC}$	Supply voltage	Operating		2	3.6	V
		Data retention only		1.5	1.5	
$V_{IH}$	High-level input voltage	$V_{CC} = 1.65$ V to 1.95 V		$0.65 \times V_{CC}$		V
		$V_{CC} = 2.3$ V to 2.7 V		1.7		
		$V_{CC} = 2.7$ V to 3.6 V		2	2	
$V_{IL}$	Low-level input voltage	$V_{CC} = 1.65$ V to 1.95 V		$0.35 \times V_{CC}$		V
		$V_{CC} = 2.3$ V to 2.7 V		0.7		
		$V_{CC} = 2.7$ V to 3.6 V		0.8	0.8	
$V_I$	Input voltage	0	5.5	0	5.5	V
$V_O$	Output voltage	High or low state		0	$V_{CC}$	V
		3 state		0	5.5	
$I_{OH}$	High-level output current	$V_{CC} = 1.65$ V		–4		mA
		$V_{CC} = 2.3$ V		–8		
		$V_{CC} = 2.7$ V		–12		
		$V_{CC} = 3$ V		–24		
$I_{OL}$	Low-level output current	$V_{CC} = 1.65$ V		4		mA
		$V_{CC} = 2.3$ V		8		
		$V_{CC} = 2.7$ V		12		
		$V_{CC} = 3$ V		24		
$\Delta t/\Delta v$	Input transition rise or fall rate	0	6	0	6	ns/V
$T_A$	Operating free-air temperature	–55	125	–40	85	°C

NOTE 4: All unused inputs of the device must be held at  $V_{CC}$  or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	SN54LVC574A			SN74LVC574A			UNIT	
			MIN	TYP†	MAX	MIN	TYP†	MAX		
V <sub>OH</sub>	I <sub>OH</sub> = -100 μA	1.65 V to 3.6 V				V <sub>CC</sub> -0.2			V	
		2.7 V to 3.6 V	V <sub>CC</sub> -0.2							
	I <sub>OH</sub> = -4 mA	1.65 V			1.2					
	I <sub>OH</sub> = -8 mA	2.3 V			1.7					
	I <sub>OH</sub> = -12 mA	2.7 V			2.2					
		3 V			2.4					
I <sub>OH</sub> = -24 mA	3 V			2.2						
V <sub>OL</sub>	I <sub>OL</sub> = 100 μA	1.65 V to 3.6 V				0.2			V	
		2.7 V to 3.6 V			0.2					
	I <sub>OL</sub> = 4 mA	1.65 V			0.45					
	I <sub>OL</sub> = 8 mA	2.3 V			0.7					
	I <sub>OL</sub> = 12 mA	2.7 V			0.4					
		3 V			0.55					
I <sub>OL</sub> = 24 mA	3 V			0.55						
I <sub>I</sub>	V <sub>I</sub> = 0 to 5.5 V	3.6 V			±5			μA		
I <sub>off</sub>	V <sub>I</sub> or V <sub>O</sub> = 5.5 V	0			±10			μA		
I <sub>OZ</sub>	V <sub>O</sub> = 0 to 5.5 V	3.6 V			±15			μA		
I <sub>CC</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	3.6 V	I <sub>O</sub> = 0	10			10			μA
	3.6 V ≤ V <sub>I</sub> ≤ 5.5 V‡			10			10			
ΔI <sub>CC</sub>	One input at V <sub>CC</sub> - 0.6 V, Other inputs at V <sub>CC</sub> or GND	2.7 V to 3.6 V			500			500		μA
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V			4			4		pF
C <sub>o</sub>	V <sub>O</sub> = V <sub>CC</sub> or GND	3.3 V			5.5			5.5		pF

† All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.

‡ This applies in the disabled state only.

**timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)**

		SN54LVC574A				UNIT
		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		
		MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency	150		150		MHz
t <sub>w</sub>	Pulse duration, CLK high or low	3.3		3.3		ns
t <sub>su</sub>	Setup time, data before CLK↑	2		2		ns
t <sub>h</sub>	Hold time, data after CLK↑	2		2		ns

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timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

	SN74LVC574A								UNIT
	V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		
	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>clock</sub> Clock frequency		†		†		150		150	MHz
t <sub>w</sub> Pulse duration, CLK high or low	†		†		3.3		3.3		ns
t <sub>su</sub> Setup time, data before CLK↑	†		†		2		2		ns
t <sub>h</sub> Hold time, data after CLK↑	†		†		1.5		1.5		ns

† This information was not available at the time of publication.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN54LVC574A				UNIT
			V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		
			MIN	MAX	MIN	MAX	
f <sub>max</sub>			150		150		MHz
t <sub>pd</sub>	CLK	Q		8	1	7	ns
t <sub>en</sub>	$\overline{\text{OE}}$	Q		9	1	7.5	ns
t <sub>dis</sub>	$\overline{\text{OE}}$	Q		7	0.5	6.4	ns

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN74LVC574A								UNIT
			V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>			†		†		150		150		MHz
t <sub>pd</sub>	CLK	Q	†	†	†	†		8	2.2	7	ns
t <sub>en</sub>	$\overline{\text{OE}}$	Q	†	†	†	†		8.5	1.5	7.5	ns
t <sub>dis</sub>	$\overline{\text{OE}}$	Q	†	†	†	†		7	1.7	6.4	ns
t <sub>sk(o)</sub> †										1	ns

† This information was not available at the time of publication.

‡ Skew between any two outputs of the same package switching in the same direction

operating characteristics, T<sub>A</sub> = 25°C

PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 1.8 V ± 0.15 V	V <sub>CC</sub> = 2.5 V ± 0.2 V	V <sub>CC</sub> = 3.3 V ± 0.3 V	UNIT
			TYP	TYP	TYP	
C <sub>pd</sub> Power dissipation capacitance per flip-flop	Outputs enabled	f = 10 MHz	†	†	43	pF
	Outputs disabled		†	†	15	

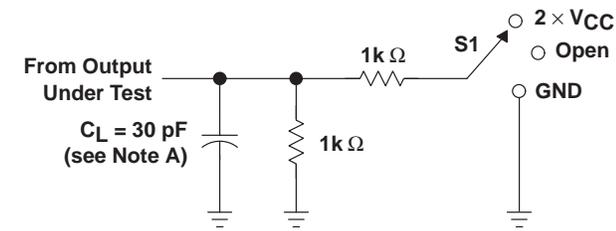
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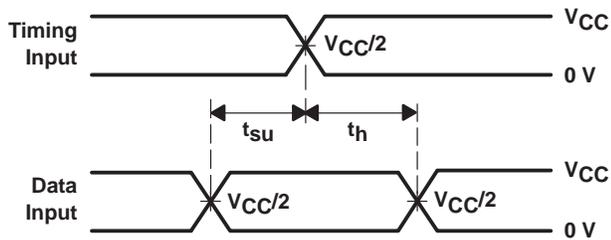
## PARAMETER MEASUREMENT INFORMATION

$$V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$$

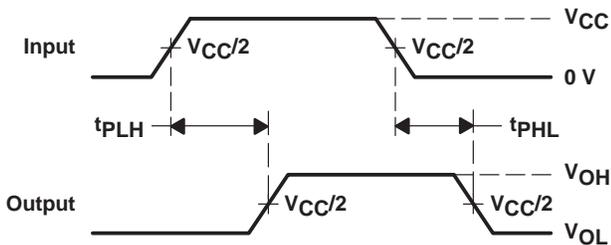


LOAD CIRCUIT

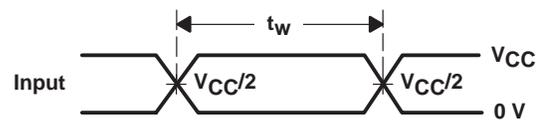
TEST	S1
$t_{pd}$	Open
$t_{PLZ}/t_{PZL}$	2 $\times$ $V_{CC}$
$t_{PHZ}/t_{PZH}$	Open



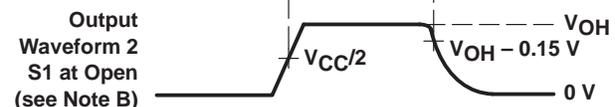
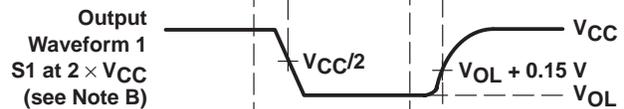
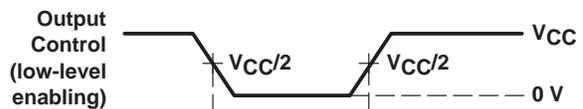
VOLTAGE WAVEFORMS  
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS  
PROPAGATION DELAY TIMES



VOLTAGE WAVEFORMS  
PULSE DURATION



VOLTAGE WAVEFORMS  
ENABLE AND DISABLE TIMES

- NOTES:
- $C_L$  includes probe and jig capacitance.
  - Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50 \Omega$ ,  $t_r \leq 2 \text{ ns}$ ,  $t_f \leq 2 \text{ ns}$ .
  - The outputs are measured one at a time with one transition per measurement.
  - $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

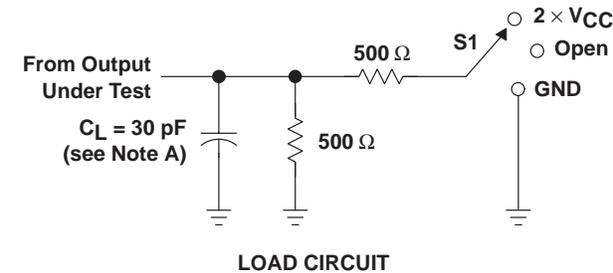
Figure 1. Load Circuit and Voltage Waveforms

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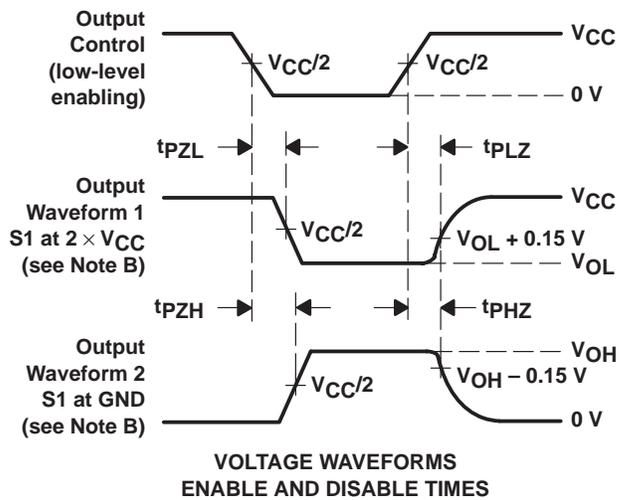
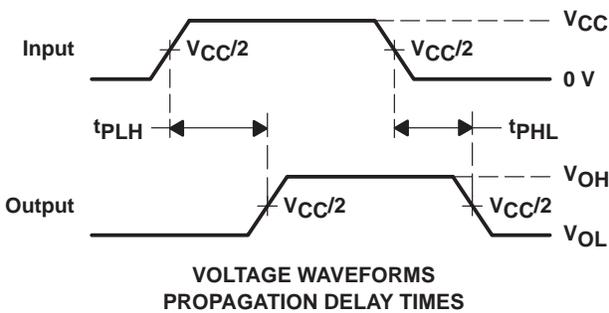
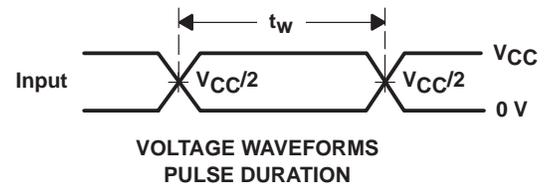
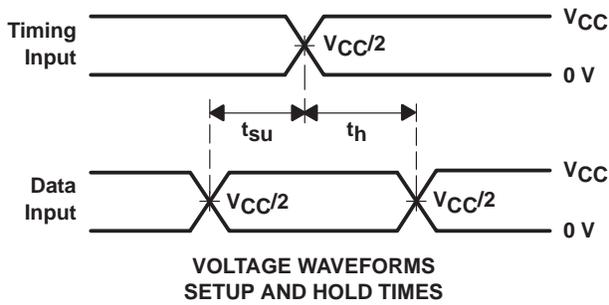
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## PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$



TEST	S1
$t_{pd}$	Open
$t_{PLZ}/t_{PZH}$	$2 \times V_{CC}$
$t_{PHZ}/t_{PHZ}$	GND



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  - D. The outputs are measured one at a time with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

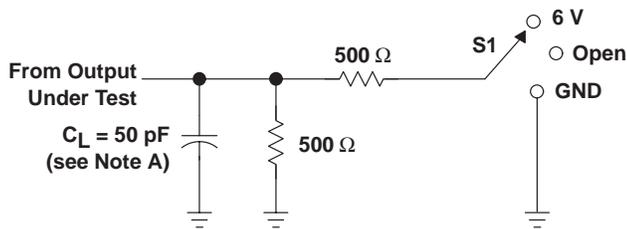
**Figure 2. Load Circuit and Voltage Waveforms**

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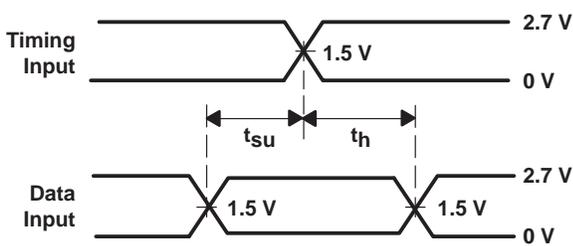
## PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 2.7\text{ V AND } 3.3\text{ V} \pm 0.3\text{ V}$

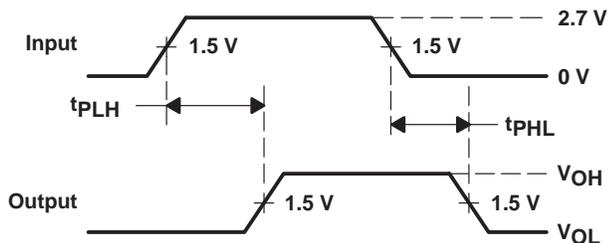


LOAD CIRCUIT

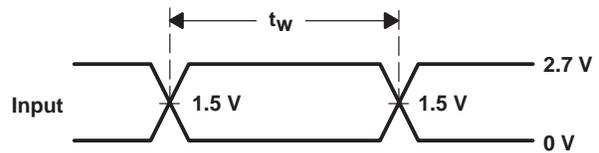
TEST	S1
$t_{pd}$	Open
$t_{PLZ}/t_{PZL}$	6 V
$t_{PHZ}/t_{PZH}$	GND



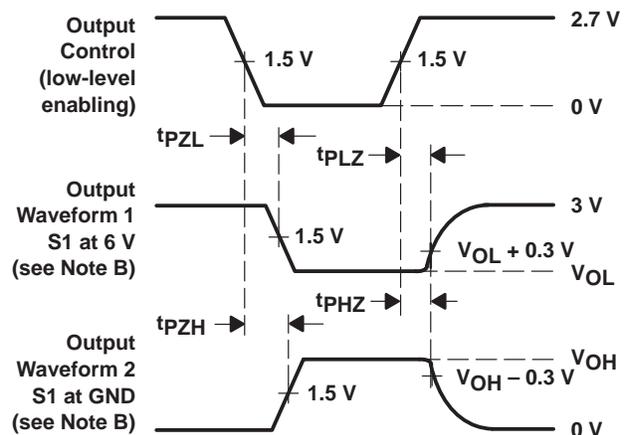
VOLTAGE WAVEFORMS  
SETUP AND HOLD TIMES



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VOLTAGE WAVEFORMS  
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 D. The outputs are measured one at a time with one transition per measurement.  
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 F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .  
 G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

Figure 3. Load Circuit and Voltage Waveforms

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